Searc	rch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/511,678	NAKAYAMA ET AL.	NAKAYAMA ET AL.
Examiner	Art Unit	Art Unit
Son T. Nguyen	3643	3643

SEARCHED			
Class	Subclass	Date	Examiner
		-	-
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		•	

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE:	EXMR	
previous search updated	10/14/2007	STN	
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